# Versatility of superconducting Hafnium for transition edge sensor bolometers



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#### **TES bolometer parameters**

Superconducting Transition  $R_n$  $\alpha = \frac{T}{R} \frac{\mathrm{d}R}{\mathrm{d}T}$ Resistance  $R_{res}$  $T_c$ Temperature  $\rightarrow$ 

Typical CMB targets:

• T<sub>c</sub> ~ 165 mK

•  $\alpha \gtrsim 100$ 

- Compatible with detector fab
- > Reproducible
- Uniform across wafer
- Does not degrade over time

## **Example of TES material: Aluminum Manganese**

#### Dale Li et al. (2016)

- Steep transition
- High uniformity across wafer
- Sensitive to fabrication temperature



- Mn dopant coarsely sets T<sub>c</sub>
- Film thickness affects T
- Bake temperature fine-tunes T



#### Hafnium: an attractive alternative

- Single element
- ~1 Ω/□ sheet resistance
  (250 nm film, measured at 1 K)
- Tunable  $T_c \sim 130 400 \text{ mK}$ 
  - Heated sputter deposition
  - Ideal range for CMB experiments



### **Example Hf detector efforts**

#### Superconducting tunnel junctions: Kraft et al. (1998)

- Photon counting spectrometers for application in astrophysics
  - 100 nm Hf film, T<sub>2</sub> ~ 130 mK

#### **TES calorimeters:** Adriana Lita et al. (2009)

- Hf calorimeter: "transition broadened considerably"
  - Hf film as deposited: 30 nm,  $T_{a} \sim 195$  mK,  $\Delta T \sim 3$  mK,  $R_{a} \sim 12 \Omega$
  - TES buried under SiN
  - Final TES T<sub>2</sub> ~ 140 190 mK

#### **MKID:** Nicholas Zobrist et al. (2019) & Gregoire Coiffard et al. (2020)

- Successful demonstration of Hf OIR MKID arrays
  - Q<sub>i</sub> ~ 77,000
  - $T_c' = 395 \text{ mK}, \Delta T \sim 5 \text{ mK}$   $\succ$  Room temp deposition

#### Heated sputter deposition



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## **TES bolometer fabrication process**

- 0) 675 μm Si Wafer + SiN (2.0 μm, low-stress) + SiO<sub>2</sub> (0.45 μm)
- 1) Hf: sputter 247 nm @ 500°C Cl<sub>2</sub> plasma etch, DI termination
- 2) SiN: PECVD 500 nm N2 preclean, CHF<sub>3</sub> + O<sub>2</sub> plasma etch
- 3) Nb: sputter 600 nm @ room temp Cl<sub>2</sub> plasma etch, DI termination
- 4) Pd: 1 µm e-beam evaporation
- 5) DRIE release bolometer
- 6) Stealth dicing



STAR

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## Designing low R<sub>n</sub>

- Unpatterned ~ 250 nm film
  - $R_n \sim 1 \Omega/\Box$ (~ 1 K measurement)
- Reduce R<sub>n</sub> via interdigitated design
- Design  $R_n$  to range from 1  $\Omega \rightarrow$  17 m $\Omega$



#### **Prototype wafer**



## Results - achieving stable $T_c$ , high $\alpha$ , low $R_n$



- $\checkmark$  Unchanged T<sub>c</sub> (~ 5 mK variation across wafer)
- ✓ Smooth & steep transition
- ✓ Low R<sub>n</sub> via interdigitated design

## Results - achieving stable $T_c$ , high $\alpha$ , low $R_n$





#### Low- $R_n$ style (20 m $\Omega$ )





## Achieving high yield

- Stress in Nb film  $\rightarrow$  Hf delamination
- Solution: Al lift off, fabricated full CMB detector stack
- Good superconducting contact & no halos

#### Delamination around Nb contact



#### Full CMB detector stack



#### Good superconducting contact 3.0 2.5 2.0 1.5 1.0 0.5 $\alpha_{0.5Rn} \ge 200$ $T_c^* = 185.4 \pm 0.6 \text{ mK}$

250

Temperature [mK]

0.0

200

\*New Hf target, uncalibrated

350

400 12

300

## Summary

Hf is an attractive detector material

- $T_c$  is tunable and stable with heated deposition
- $\alpha$ : steep transition with high loop gain
- Interdigitated design effectively reduces R<sub>n</sub>
- Successful fabrication of a full CMB detector stack

## Thank You.

#### Abstract

Several current and next generation cosmic microwave background (CMB) polarimetry experiments employ transition edge sensor (TES) bolometers whose operating temperature is ~100 milli-Kelvin, requiring a critical temperature (T<sub>a</sub>) around 170 milli-Kelvin. Aluminum Manganese (AlMn) has been successfully used as the superconducting metal by several groups for CMB experiments. However, achieving a repeatable and stable T<sub>c</sub> requires careful thermal management that puts bounds on fabrication processes. We studied an alternative superconducting metal – Hafnium (Hf) is an attractive alternative as its bulk T<sub>c</sub> is well matched to our needs and can also be deposited as a thin film as demonstrated by the microwave kinetic inductance detector (MKID) community. One critical differentiation between past Hf MKID fabrication processes and our own, is our use of a heated sputter deposition that enables us to finely tune the T<sub>c</sub> to our desired target. Furthermore, the T<sub>c</sub> remains robust against subsequent exposure to heat as long as the initial deposition temperature is not exceeded. As the deposition temperatures are high (ranging from 300°C - 550°C, depending on the desired T\_), there is ample thermal budget for continued fabrication processes while maintaining a stable T<sub>c</sub>. Additionally, by using an interdigitated geometry we are able to precisely design the normal resistance of the TES to anywhere between 1 Ohm and 10 milli-Ohm, making these TESs compatible with CMB experiments that use both time-domain as well as frequency-domain and microwave multiplexing readout systems. We present our findings of a Hf based TES bolometer designed for CMB experiments.